



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(ON)} Max	I _D T _A = +25°C
Q1	30V	$16m\Omega$ @ $V_{GS} = 10V$	8.2A
Qı	30 V	$20m\Omega$ @ $V_{GS} = 4.5V$	7.3A
Q2	-30V	$28m\Omega$ @ $V_{GS} = -10V$	-6.2A
Q2	-307	$38m\Omega$ @ $V_{GS} = -4.5V$	-5.2A

Description

This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$), yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Applications

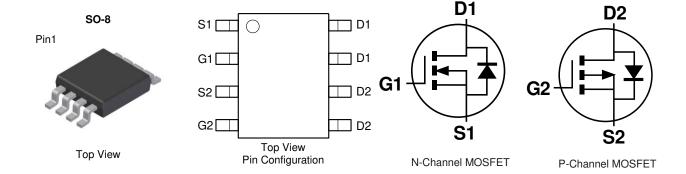
- DC-DC Converters
- Power Management Functions
- Backlighting

Features and Benefits

- Low Input Capacitance
- Low On-Resistance
- · Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.074 grams (Approximate)



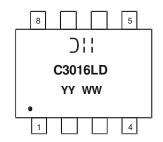
Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3016LSD-13	SO-8	2.500/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



⊃¦¦ = Manufacturer's Marking
 C3016LD = Product Type Marking Code
 YYWW = Date Code Marking
 YY or YY = Year (ex: 15 = 2015)
 WW = Week (01 - 53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value Q1	Value Q2	Units		
Drain-Source Voltage	V _{DSS}	30	-30	V		
Gate-Source Voltage	V _{GSS}	±20	±20	V		
Continuous Dusin Current (Note C) V 10V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	8.2 6.5	-6.2 -5.0	А
Continuous Drain Current (Note 6) V _{GS} = 10V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	10.5 8.4	-8.0 -6.4	А
Maximum Body Diode Forward Current (Note 6)	I _S	2.5	-2.5	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1	I _{DM}	80	-40	Α		
Avalanche Current (Note 7) L = 0.1mH	I _{AS}	22	-22	Α		
Avalanche Energy (Note 7) L = 0.1mH			E _{AS}	25	25	mJ

Thermal Characteristics

Characteristic	Symbol	Value	Units		
Total Dayyar Dissination (Note 5)	T _A = +25°C	D.	1.2	W	
Total Power Dissipation (Note 5)	T _A = +70°C	P_{D}	0.8	VV	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	В	102	°C/W	
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	62		
Total Power Dissipation (Note 6)	$T_A = +25$ °C	D	1.6	W	
Total Fower Dissipation (Note 6)	T _A = +70°C	P_{D}	1.0		
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	В	78	°C/W	
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	47		
Thermal Resistance, Junction to Case (Note 6)	Rejc	12			
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C	

Electrical Characteristics (N-Channel Q1) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	$V_{DS} = 30V$, $V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)	•						
Gate Threshold Voltage	V _{GS(th)}	1.0	_	3.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D	_	12	16	mΩ	$V_{GS} = 10V, I_D = 12A$	
Static Diami-Source Off-Nesistance	R _{DS(ON)}	_	15	20		$V_{GS} = 4.5V, I_D = 10A$	
Diode Forward Voltage	V _{SD}	_	0.7	1.0	V	$V_{GS} = 0V$, $I_S = 1A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{ISS}	_	1,415	_		$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz	
Output Capacitance	Coss	_	119	_	pF		
Reverse Transfer Capacitance	C _{RSS}	_	82	_			
Gate Resistance	R _G	_	2.6	3.2	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Q_{G}	_	11.3	_		V _{DS} = 15V, I _D = 12A	
Total Gate Charge (V _{GS} = 10V)	Q_{G}	_	25.1	_	nC		
Gate-Source Charge	Q _{GS}	_	3.5	_	110		
Gate-Drain Charge	Q_{GD}	_	3.6	_			
Turn-On Delay Time	t _{D(ON)}		4.8	_			
Turn-On Rise Time	t _R		16.5	_	20	$V_{DD} = 15V, V_{GS} = 10V,$	
Turn-Off Delay Time	t _{D(OFF)}	_	26.1	_	ns	$R_L=1.25\Omega,R_G=3\Omega,$	
Turn-Off Fall Time	t _F	_	5.6	_			

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

^{6.} Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.

^{7.} UIS in production with L = 0.1mH, starting $T_A = +25^{\circ}C$.

^{8.} Short duration pulse test used to minimize self-heating effect.

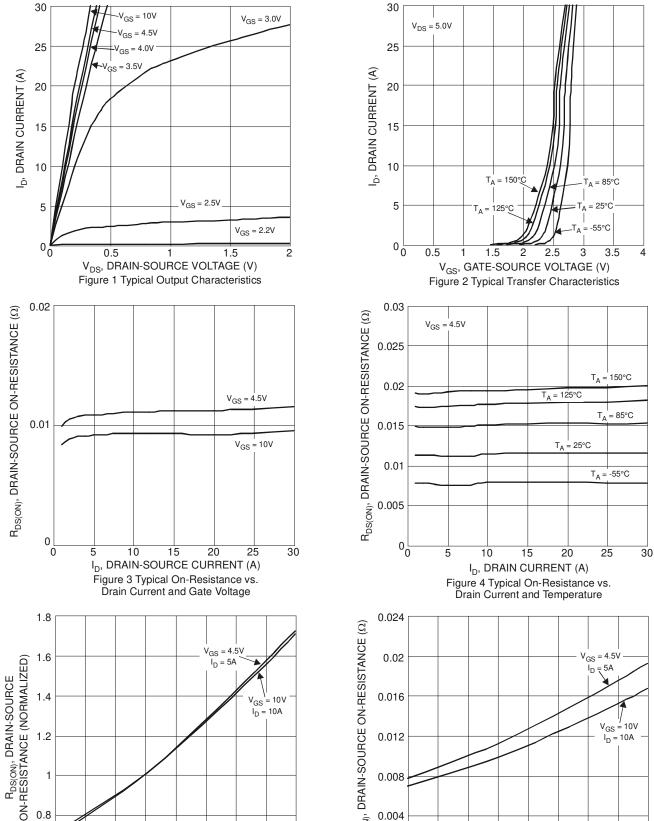
^{9.} Guaranteed by design. Not subject to product testing.



Electrical Characteristics (Continued) (P-Channel Q2) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)	Cyllibol	IVIIII	i yp	Wax	Onit	rest condition	
Drain-Source Breakdown Voltage	BV _{DSS}	-30		_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	-1	μΑ	V _{DS} = -30V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	$V_{GS(th)}$	-1.0	_	-3.0	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$	
Static Drain-Source On-Resistance	Passaus	_	21	28	mΩ	$V_{GS} = -10V, I_D = -7A$	
Static Drain-Source Off-Hesistance	R _{DS(ON)}	_	30	38		$V_{GS} = -4.5V$, $I_D = -6.2A$	
Diode Forward Voltage	V_{SD}	_	-0.7	-1.2	$V = V_{GS} = 0V, I_S = -2.1A$		
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	Ciss	_	1,241	_		V _{DS} = -15V, V _{GS} = 0V f = 1.0MHz	
Output Capacitance	Coss	_	147	_	pF		
Reverse Transfer Capacitance	C _{RSS}	_	110	_			
Gate Resistance	R_{G}	_	15	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V _{GS} = -4.5V)	Q _G	_	10.9	_		VDS = -15V, ID = -7A	
Total Gate Charge (V _{GS} = -10V)	Q_{G}	_	22	_	nC		
Gate-Source Charge	Q _{GS}	_	3.5	_	110		
Gate-Drain Charge	Q_{GD}	_	4.7	_			
Turn-On Delay Time	t _{D(ON)}	_	9.7	_			
Turn-On Rise Time	t _R	_	17.1	_	ns	VDS = -15V, ID = -7A	
Turn-Off Delay Time	t _{D(OFF)}	_	60.5	_	115	$V_{GS} = -10V$, $R_{G} = 6\Omega$	
Turn-Off Fall Time	t _F	_	40.4	_			





T_J, JUNCTION TEMPERATURE (°C) Figure 5 On-Resistance Variation with Temperature

50

75

100

125

150

25

-25

0.6 -50



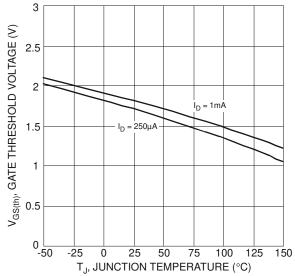


Figure 7 Gate Threshold Variation vs. Ambient Temperature

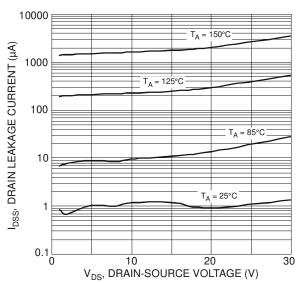
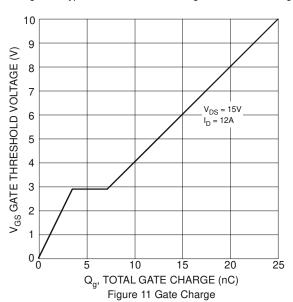
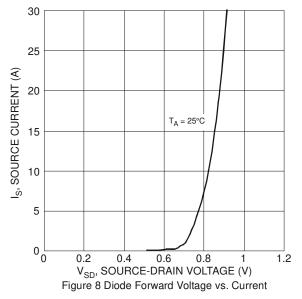
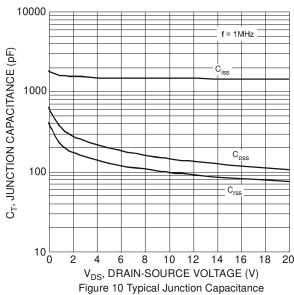
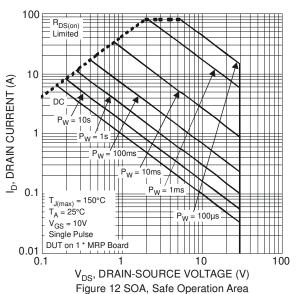


Figure 9 Typical Drain-Source Leakage Current vs. Voltage

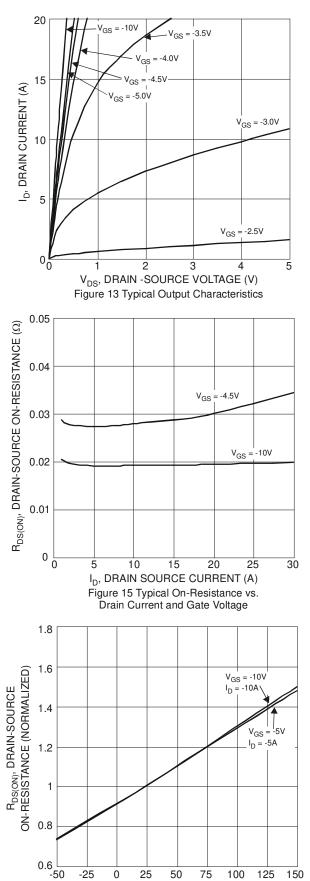






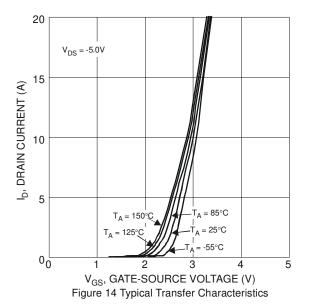


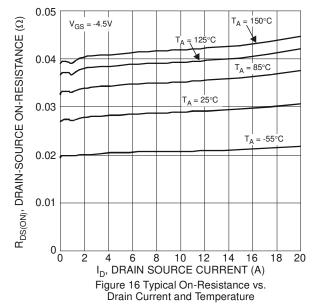


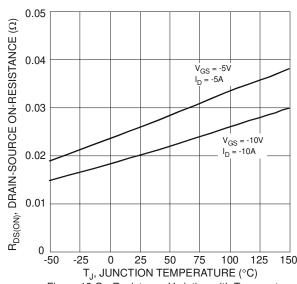


T_J, JUNCTION TEMPERATURE (°C)

Figure 17 On-Resistance Variation with Temperature









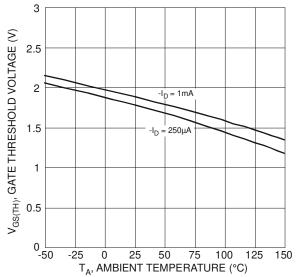


Figure 19 Gate Threshold Variation vs. Ambient Temperature

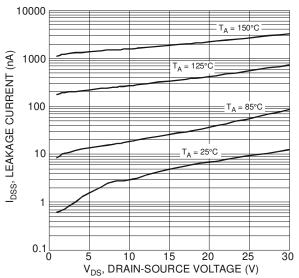
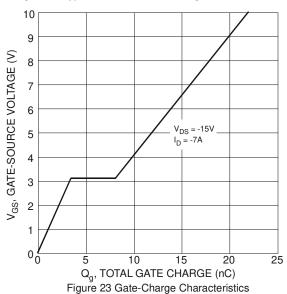
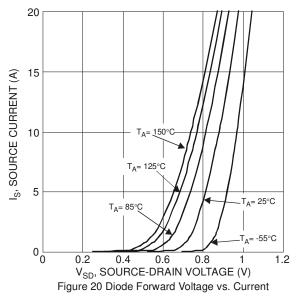
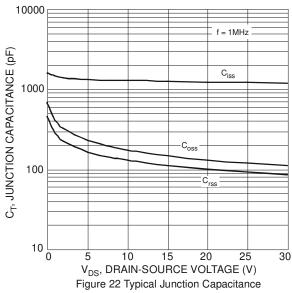
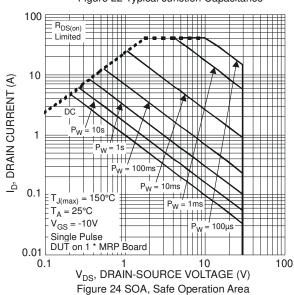


Figure 21 Typical Drain-Source Leakage Current vs. Voltage

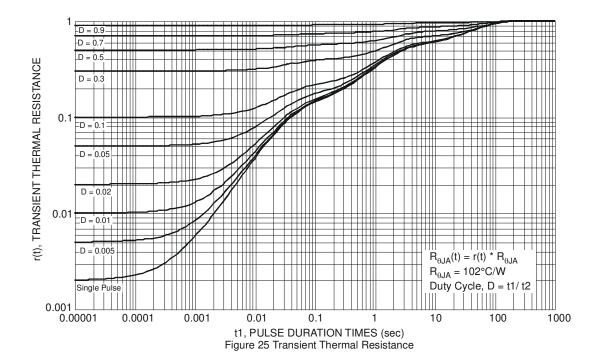






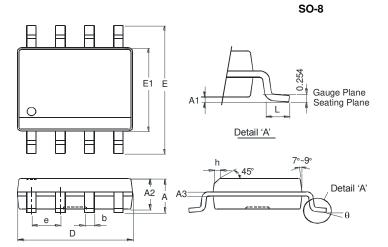








Package Outline Dimensions
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

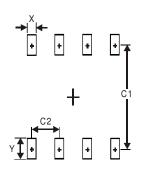


SO-8						
Dim	Min	Max				
Α	_	1.75				
A 1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
Е	5.90	6.10				
E1	3.85	3.95				
е	1.27 Typ					
h	_	0.35				
L	0.62	0.82				
θ	0°	8°				
All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

SO-8



Dimensions	Value (in mm)				
Х	0.60				
Υ	1.55				
C1	5.4				
C2	1 27				



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